

## Admins - Demande #3323

### Disque dur interne laptop absinthe FAILING\_NOW

25/09/2018 09:45 - Frédéric Couchet

<b>Statut:</b>	Fermé	<b>Début:</b>	25/09/2018
<b>Priorité:</b>	Normale	<b>Echéance:</b>	
<b>Assigné à:</b>	Frédéric Couchet	<b>% réalisé:</b>	100%
<b>Catégorie:</b>		<b>Temps estimé:</b>	0.00 heure
<b>Version cible:</b>	Backlog	<b>Temps passé:</b>	0.00 heure
<b>Difficulté:</b>	2 Facile		

**Description**

Salut,

hier soir j'ai eu une alerte smartctl concernant mon disque dur.

Je vous mets ci-dessous le résultat de smartctl -a /dev/sda et un extrait inquiétant :

SMART overall-health self-assessment test result: FAILED!  
Drive failure expected in less than 24 hours. SAVE ALL DATA.

233 Media\_Wearout\_Indicator 0x0013 001 001 001 Pre-fail Always FAILING\_NOW 146800

Je vais relancer un test mais a priori ça ne sent pas bon. Même si je ne sais pas vraiment interpréter le résultat de smartctl. Par sécurité je vais commander un disque.

Sur

<https://serverfault.com/questions/316150/how-to-determine-number-of-write-cycles-or-expected-life-for-ssd-under-linux>

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That still doesn't guarantee when/if you'll see failures or errors. Drive could fail tomorrow, could fail in three years.
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voir aussi

[https://www.thomas-krenn.com/en/wiki/SMART\\_attributes\\_of\\_Intel\\_SSDs](https://www.thomas-krenn.com/en/wiki/SMART_attributes_of_Intel_SSDs)

Selon smartctl mon disque est SATA Version is: SATA 3.1, 6.0 Gb/s (current: 6.0 Gb/s)  
C'est un 250 Go, je prendrais bien une capacité un peu supérieure (je suis à 90% d'utilisation disque).

LDLC propose <https://www.ldlc.com/informatique/pièces-informatique/disque-ssd/c4698/+fv63-10416+fv32-10948.html>

Des conseils/suggestions par rapport à la liste LDLC ?

Un changement de disque M.2 est facile à faire ? Il faut un outillage spécifique ?

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1. smartctl -a /dev/sda

```
smartctl 6.6 2016-05-31 r4324 [x86_64-linux-4.17.0-3-amd64] (local build)
Copyright (C) 2002-16, Bruce Allen, Christian Franke, www.smartmontools.org

=== START OF INFORMATION SECTION ===
Device Model:   SAMSUNG MZNTY256HDHP-000L7
Serial Number:  S305NYAH634440
LU WWN Device Id:  5 002538 d00000000
Firmware Version: MAT23L6Q
User Capacity:  256 060 514 304 bytes [256 GB]
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Sector Size: 512 bytes logical/physical  
 Rotation Rate: Solid State Device  
 Form Factor: M.2  
 Device is: Not in smartctl database [for details use: -P showall]  
 ATA Version is: ACS-2, ATA8-ACS T13/1699-D revision 4c  
 SATA Version is: SATA 3.1, 6.0 Gb/s (current: 6.0 Gb/s)  
 Local Time is: Tue Sep 25 09:38:24 2018 CEST  
 SMART support is: Available - device has SMART capability.  
 SMART support is: Enabled

=== START OF READ SMART DATA SECTION ===  
 SMART overall-health self-assessment test result: FAILED!  
 Drive failure expected in less than 24 hours. SAVE ALL DATA.  
 See vendor-specific Attribute list for failed Attributes.

General SMART Values:  
 Offline data collection status: (0x00) Offline data collection activity was never started.  
 Auto Offline Data Collection: Disabled.  
 Self-test execution status: ( 72) The previous self-test completed having a test element that failed and the test element that failed is not known.  
 Total time to complete Offline data collection: ( 0) seconds.  
 Offline data collection capabilities: (0x53) SMART execute Offline immediate.  
 Auto Offline data collection on/off support.  
 Suspend Offline collection upon new command.  
 No Offline surface scan supported.  
 Self-test supported.  
 No Conveyance Self-test supported.  
 Selective Self-test supported.  
 SMART capabilities: (0x0003) Saves SMART data before entering power-saving mode.  
 Supports SMART auto save timer.  
 Error logging capability: (0x01) Error logging supported.  
 General Purpose Logging supported.  
 Short self-test routine recommended polling time: ( 2) minutes.  
 Extended self-test routine recommended polling time: ( 85) minutes.  
 SCT capabilities: (0x003d) SCT Status supported.  
 SCT Error Recovery Control supported.  
 SCT Feature Control supported.  
 SCT Data Table supported.

SMART Attributes Data Structure revision number: 1

Vendor Specific SMART Attributes with Thresholds:

ID#	ATTRIBUTE_NAME	FLAG	VALUE	WORST	THRESH	TYPE	UPDATED	WHEN_FAILED	RAW_VALUE
5	Reallocated_Sector_Ct	0x0033	100	100	010	Pre-fail Always	-	0	
9	Power_On_Hours	0x0032	097	097	000	Old_age Always	-	10171	
12	Power_Cycle_Count	0x0032	098	098	000	Old_age Always	-	1406	
170	Unknown_Attribute	0x0032	100	100	010	Old_age Always	-	0	
171	Unknown_Attribute	0x0032	100	100	010	Old_age Always	-	0	
172	Unknown_Attribute	0x0032	100	100	010	Old_age Always	-	0	
173	Unknown_Attribute	0x0033	006	006	005	Pre-fail Always	-	793	
174	Unknown_Attribute	0x0032	099	099	000	Old_age Always	-	62	
178	Used_Rsvd_Blk_Cnt_Chip	0x0013	100	100	010	Pre-fail Always	-	0	
180	Unused_Rsvd_Blk_Cnt_Tot	0x0013	100	100	010	Pre-fail Always	-	1863	
184	End-to-End_Error	0x0033	100	100	097	Pre-fail Always	-	0	
187	Reported_Uncorrect	0x0032	100	100	000	Old_age Always	-	0	
194	Temperature_Celsius	0x0032	063	038	000	Old_age Always	-	37 (Min/Max 0/62)	
199	UDMA_CRC_Error_Count	0x003e	100	100	000	Old_age Always	-	0	
233	Media_Wearout_Indicator	0x0013	001	001	001	Pre-fail Always	FAILING_NOW	146800	
241	Total_LBAs_Written	0x0032	099	099	000	Old_age Always	-	25927	
242	Total_LBAs_Read	0x0032	099	099	000	Old_age Always	-	38221	

249 Unknown\_Attribute 0x0032 099 099 000 Old\_age Always - 203184

SMART Error Log Version: 1  
No Errors Logged

SMART Self-test log structure revision number 1

Num	Test_Description	Status	Remaining	LifeTime(hours)	LBA_of_first_error
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1. 1	Short offline	Completed: unknown failure	80%	10171	0
2. 2	Short offline	Completed without error	00%	0	-

SMART Selective self-test log data structure revision number 1

SPAN	MIN_LBA	MAX_LBA	CURRENT_TEST_STATUS
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1	0	0	Not_testing
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2	0	0	Not_testing
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3	0	0	Not_testing
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4	0	0	Not_testing
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5	0	0	Not_testing
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255	0	65535	Read_scanning was never started
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Selective self-test flags (0x0):

After scanning selected spans, do NOT read-scan remainder of disk.

If Selective self-test is pending on power-up, resume after 0 minute delay.

## Historique

### #1 - 25/09/2018 10:24 - Frédéric Couchet

Commande du disque Samsung SSD 860 EVO 500 Go M.2 <https://www.ldlc-pro.com/fiche/PB00243256.html> effectuée, livraison mercredi.

### #2 - 03/10/2018 15:10 - Frédéric Couchet

- Statut changé de Nouveau à Fermé

- % réalisé changé de 0 à 100

Disque reçu, transféré sur laptop, réinstallation d'une Debian Buster faite, wiki mis à jour.

### #3 - 26/12/2020 02:21 - Christian P. Momon

- Assigné à mis à Frédéric Couchet